

Notice of References Cited		Application/Control No. 10/801,398	Applicant(s)/Patent Under Reexamination SOHEILI ET AL.	
		Examiner EDWARD J. KIM	Art Unit 2455	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0014085 A1	08-2001	Johansson et al.	370/329
*	B	US-6,301,484 B1	10-2001	Rogers et al.	455/466
*	C	US-2002/0028709 A1	03-2002	Finer et al.	463/42
*	D	US-2002/0123359 A1	09-2002	Wei et al.	455/466
*	E	US-2003/0085522 A1	05-2003	Loder, John	273/292
*	F	US-2003/0110211 A1	06-2003	Danon, David Jean-Philippe	709/203
*	G	US-2003/0114224 A1	06-2003	Anttila et al.	463/40
*	H	US-2004/0078424 A1	04-2004	Yairi et al.	709/203
*	I	US-2004/0121785 A1	06-2004	Vance et al.	455/466
*	J	US-6,801,793 B1	10-2004	Aarnio et al.	455/566
*	K	US-2004/0235454 A1	11-2004	Rowitch et al.	455/411
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.